

Notice of References Cited	Application/Control No. 10/532,727	Applicant(s)/Patent Under Reexamination OGURA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 2002-153211	05-2002	Japan		
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Translation of Detailed Description of JP 2002-153211 (published 05-2002)
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